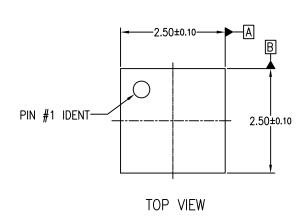
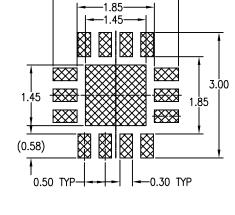
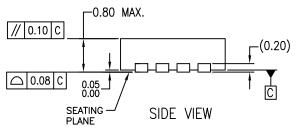
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	REVISIONS										
LTR	DESCRIPTION	EDCN	DATE	BY/APP'D							
Α	RELEASE TO DOCUMENT CONTROL		25-2-2004	FEITAN							

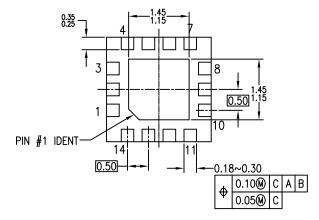




-3.00-



RECOMMENDED LAND PATTERN



BOTTOM VIEW

NOTES:

- A. NO JEDEC REGISTRATION
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994

	APF	PROVALS	DATE	FAIR		_		
	DRAWN	FEITAN	09-02-2004	SEMICO	NDUC.	Bayan TOR⊛11900,	Lepas, FIZ, Penang, Malays	ia.
	DFTG. C	HK.		4.41	5	D 0.51		_
ı	ENGR. C	CHK.		14LD, MLP, 2.5MM SQUARE				
	PROJECTION		SCALE	SIZE	DRAWING NUMBER		REV	
			N/A	N/A	MKT-	-MLP14D	Α	
		INCH [MM]	7	DO NOT	SCALE	DRAWING	SHEET 1 of	1

MLP14DrevA